

Is Now Part of



## **ON Semiconductor**®

# To learn more about ON Semiconductor, please visit our website at <u>www.onsemi.com</u>

Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (\_), the underscore (\_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (\_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at <a href="mailto:www.onsemi.com">www.onsemi.com</a>. Please email any questions regarding the system integration to <a href="mailto:Fairchild\_questions@onsemi.com">Fairchild\_questions@onsemi.com</a>.

ON Semiconductor and the ON Semiconductor logo are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or unavteries, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out or i, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that ON Semiconductor was negligent regarding the design or manufacture of the part. ON Semiconductor and is officers, employees, uniotificated use, even if such claim any manner.



- Max  $r_{DS(on)}$  =105m $\Omega$  at V<sub>GS</sub> = -10V, I<sub>D</sub> = -2.9A
- Max  $r_{DS(on)}$  =135m $\Omega$  at V<sub>GS</sub> = -4.5V, I<sub>D</sub> = -2.5A
- Qualified to AEC Q101

FAIRCHILD

RoHS Compliant



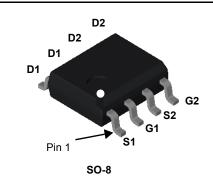
#### **General Description**

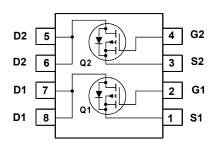
These P-channel logic level specified MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench<sup>®</sup> process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

These devices are well suited for portable electronics applications: load switching and power management, battery charging and protection circuits.

#### **Applications**

- Load Switch
- Power Management





#### MOSFET Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter	Ratings	Units		
V <sub>DS</sub>	Drain to Source Voltage		-60	V	
V <sub>GS</sub>	Gate to Source Voltage		±20	V	
I <sub>D</sub>	Drain Current -Continuous	(Note 1a)	-2.9	•	
	-Pulsed		-12	A	
E <sub>AS</sub>	Single Pulse Avalanche Energy	(Note 3)	54	mJ	
	Power Dissipation for Dual Operation		2		
PD	Power Dissipation	(Note 1a)	1.6	W	
	Power Dissipation	(Note 1b)	0.9		
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C	

#### **Thermal Characteristics**

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	40	°C/W
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient (Note 1a)	78	C/VV

#### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDS9958	FDS9958_F085	SO-8	330mm	12mm	2500units

1

January 2016

Cteristics         Drain to Source Breakdown Voltage         Breakdown Voltage Temperature         Coefficient         Zero Gate Voltage Drain Current         Gate to Source Leakage Current	$\begin{split} I_{D} &= -250 \mu A, \ V_{GS} = 0 V \\ I_{D} &= -250 \mu A, \ referenced \ to \ 25^{\circ} C \\ V_{DS} &= -48 V, \\ V_{GS} &= 0 V \\ V_{GS} &= \pm 20 V, \ V_{DS} &= 0 V \\ \end{split}$	-60	-52	-1	V mV/°C
Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current	$I_D = -250 \mu A$ , referenced to 25°C $V_{DS} = -48V$ ,	-60	-52	-1	
Coefficient Zero Gate Voltage Drain Current	$I_D = -250 \mu A$ , referenced to 25°C $V_{DS} = -48V$ ,		-52	-1	mV/°C
Zero Gate Voltage Drain Current	V <sub>DS</sub> = -48V,		-52	-1	mv/ O
-				-1	
Gate to Source Leakage Current				-100	μA
	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA
teristics					
	$V_{CS} = V_{DS}$ . In = -250µA	-1.0	-1.6	-3.0	V
Gate to Source Threshold Voltage				2.0	-
Temperature Coefficient	$I_D = -250 \mu A$ , referenced to 25°C		4		mV/°C
Static Drain to Source On Resistance	V <sub>GS</sub> = -10V, I <sub>D</sub> = -2.9A		82	105	
	$V_{GS}$ = -4.5V, $I_{D}$ = -2.5A		103	135	mΩ
			131	190	
Forward Transconductance	$V_{DD} = -5V, I_D = -2.9A$		7.7		S
Characteristics					
Input Capacitance	$V_{\rm DS} = -30V, V_{\rm GS} = 0V,$		765	1020	pF
Output Capacitance			90	120	pF
Reverse Transfer Capacitance			40	65	pF
Characteristics					
			6	12	ns
Rise Time			3	10	ns
Turn-Off Delay Time	$-V_{GS} = -10V, R_{GEN} = 6\Omega$		27	43	ns
Fall Time			6	12	ns
Total Gate Charge	V <sub>GS</sub> = 0V to -10V		16	23	nC
Total Gate Charge	$V_{GS} = 0V \text{ to } -4.5V$ $V_{DD} = -30V,$		8	12	nC
Gate to Source Charge	I <sub>D</sub> = -2.9A		2		nC
Gate to Drain "Miller" Charge			3		nC
rce Diode Characteristics					
			0.0	10	V
Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_{S} = -1.3A$ (Note 2)		-0.8	-1.2	v
Source to Drain Diode Forward Voltage Reverse Recovery Time	$V_{GS} = 0V, I_S = -1.3A$ (Note 2) $-I_F = -2.9A, di/dt = 100A/\mu s$		-0.8 26	-1.2 42	ns
	Temperature Coefficient Static Drain to Source On Resistance Forward Transconductance Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge	Gate to Source Threshold Voltage Temperature Coefficient $I_D = -250\mu$ A, referenced to 25°CStatic Drain to Source On Resistance $V_{GS} = -10V, I_D = -2.9A$ Static Drain to Source On Resistance $V_{GS} = -4.5V, I_D = -2.9A$ Forward Transconductance $V_{DD} = -5V, I_D = -2.9A$ Forward Transconductance $V_{DD} = -5V, I_D = -2.9A$ CharacteristicsInput Capacitance $V_{DS} = -30V, V_{GS} = 0V, f = 1MHz$ Reverse Transfer Capacitance $V_{DS} = -30V, V_{GS} = 0V, f = 1MHz$ Turn-On Delay Time $V_{DD} = -30V, I_D = -2.9A, V_{GS} = -10V, R_{GEN} = 6\Omega$ Turn-Off Delay Time $V_{GS} = 0V \text{ to } -10V, V_{GS} = 0V \text{ to } -2.9A, V_{GS} = -30V, I_D = -2.9A, V_{GS} = -2.9A, V_{GS} = -10V, R_{GEN} = 6\Omega$ Total Gate Charge $V_{GS} = 0V \text{ to } -4.5V, I_D = -2.9A, I_D = -2.9A, V_{DD} = -30V, I_D = -2.9A, V_{GS} = -30V, I_D = -2.9A, V_{GS} = -30V, I_D = -2.9A, V_{GS} = -2.9A, V_{GS} = -10V, R_{GEN} = 6\Omega$ Total Gate Charge $V_{GS} = 0V \text{ to } -4.5V, I_D = -2.9A, I_D = -2.9A, I_D = -2.9A, V_{GS} = -2.9A, I_D = -2.9$	Gate to Source Threshold Voltage Temperature Coefficient $I_D = -250\mu A$ , referenced to $25^{\circ}C$ Static Drain to Source On Resistance $V_{GS} = -10V, I_D = -2.9A$ Static Drain to Source On Resistance $V_{GS} = -10V, I_D = -2.9A$ Forward Transconductance $V_{DD} = -5V, I_D = -2.9A$ Forward Transconductance $V_{DD} = -5V, I_D = -2.9A$ Characteristics $V_{DS} = -30V, V_{GS} = 0V, f = 1MHz$ Input Capacitance Output Capacitance $V_{DS} = -30V, V_{GS} = 0V, f = 1MHz$ Reverse Transfer Capacitance $V_{DD} = -30V, I_D = -2.9A, V_{GS} = 0V, f = 1MHz$ Turn-On Delay Time Fail Time $V_{DD} = -30V, I_D = -2.9A, V_{GS} = -10V, R_{GEN} = 6\Omega$ Total Gate Charge Gate to Source Charge $V_{GS} = 0V \text{ to } -10V, I_D = -2.9A, I_D = -2.9A,$	$ \begin{array}{c c} \mbox{Gate to Source Threshold Voltage Temperature Coefficient} & I_D = -250 \mu A, referenced to 25°C & 4 \\ I_D = -250 \mu A, referenced to 25°C & 4 \\ \hline V_{GS} = -10V, I_D = -2.9A & 82 \\ \hline V_{GS} = -4.5V, I_D = -2.9A & 103 \\ \hline V_{GS} = -10V, I_D = -2.9A, T_J = 125°C & 131 \\ \hline V_{DD} = -5V, I_D = -2.9A & 7.7 \\ \hline \end{tabular} $	$ \begin{array}{c c c c c c } \hline Gate to Source Threshold Voltage Temperature Coefficient & I_D = -250 \mu A, referenced to 25°C & 4 & \\ \hline I_D = -250 \mu A, referenced to 25°C & 4 & \\ \hline V_{GS} = -10V, \ I_D = -2.9A & 82 & 105 & \\ \hline V_{GS} = -4.5V, \ I_D = -2.9A, \ T_J = 125°C & 131 & 190 & \\ \hline V_{GS} = -10V, \ I_D = -2.9A, \ T_J = 125°C & 131 & 190 & \\ \hline Forward Transconductance & V_{DD} = -5V, \ I_D = -2.9A & 7.7 & \\ \hline \mbox{Characteristics} & & & & & & & & & \\ \hline Input Capacitance & V_{DD} = -5V, \ I_D = -2.9A & & & & & & & & & \\ \hline Input Capacitance & V_{DS} = -30V, \ V_{GS} = 0V, \ f = 1MHz & & & & & & & & & & & & \\ \hline \mbox{Characteristics} & & & & & & & & & & & & & & \\ \hline \mbox{Characteristics} & & & & & & & & & & & & & & & & & \\ \hline \mbox{Characteristics} & & & & & & & & & & & & & & & & & & \\ \hline \mbox{Characteristics} & & & & & & & & & & & & & & & & & & \\ \hline \mbox{Turn-On Delay Time} & & & & & & & & & & & & & & & & & & &$

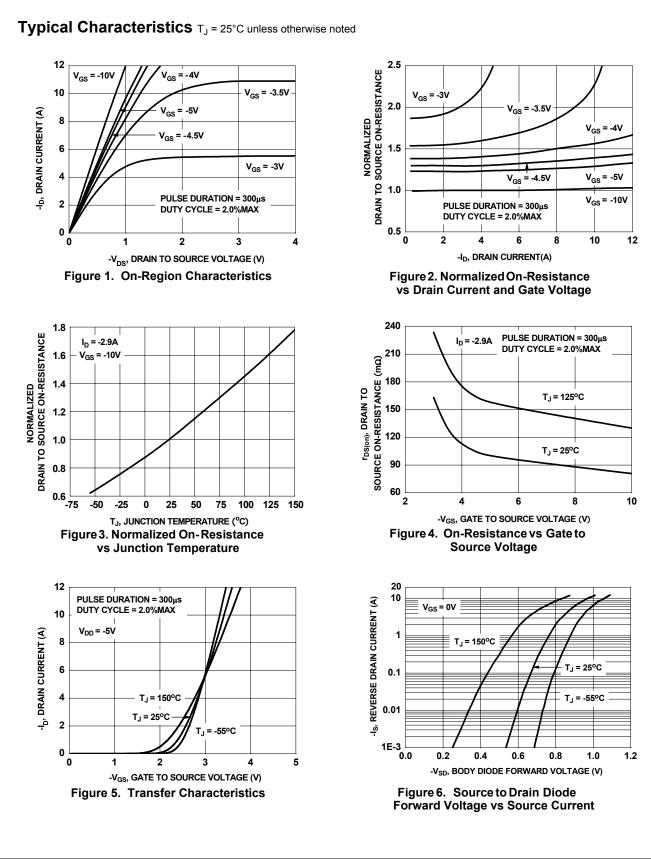
2. Pulse Test: Pulse Width <  $300\mu$ s, Duty cycle < 2.0%.

3. UIL condition: Starting  $T_J$  = 25°C, L = 3mH,  $I_{AS}$  = 6A,  $V_{DD}$  = 60V,  $V_{GS}$  = 10V.

88888

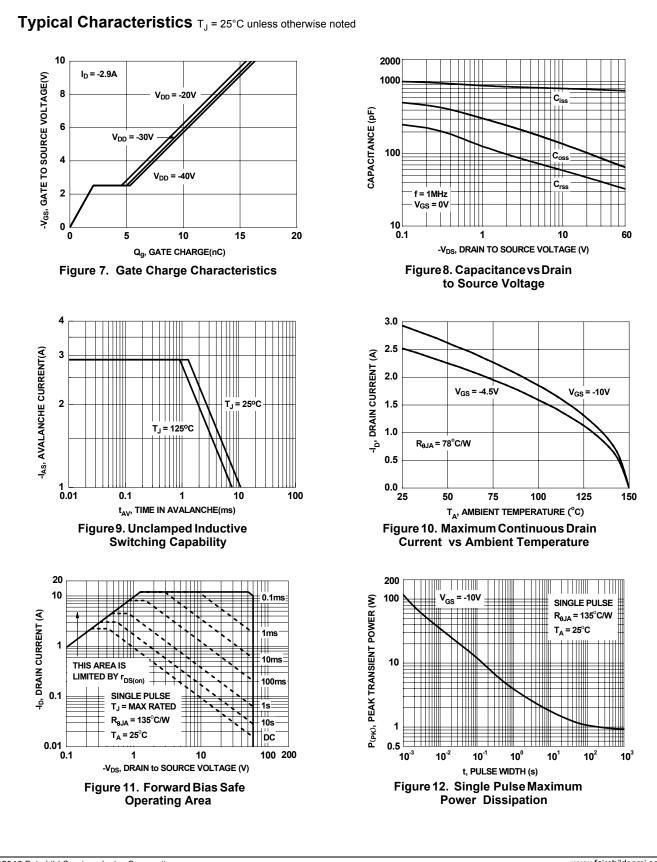
©2016 Fairchild Semiconductor Corporation FDS9958\_F085 Rev.1.2

www.fairchildsemi.com



©2016 Fairchild Semiconductor Corporation FDS9958\_F085 Rev.1.2

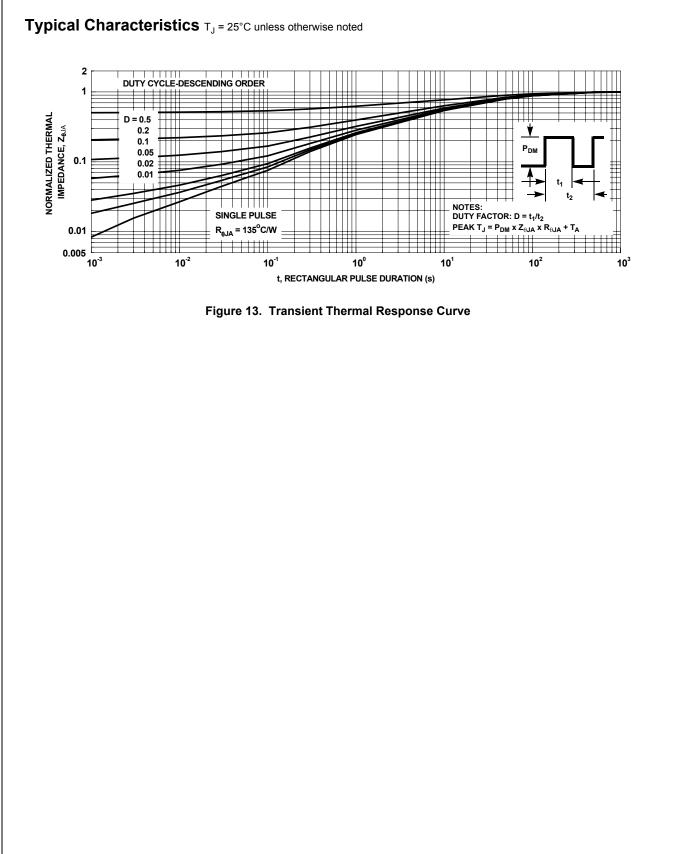
3



©2016 Fairchild Semiconductor Corporation FDS9958\_F085 Rev.A

www.fairchildsemi.com

FDS9958\_F085 Dual P-Channel PowerTrench<sup>®</sup> MOSFET



www.fairchildsemi.com

FDS9958\_F085 Dual P-Channel PowerTrench<sup>®</sup> MOSFET



ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <u>www.onsemi.com/site/pdf/Patent-Marking.pdf</u>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor has against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death ass

#### PUBLICATION ORDERING INFORMATION

#### LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Japan Customer Focus Center Phone: 81-3-5817-1050 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

© Semiconductor Components Industries, LLC

### **Mouser Electronics**

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

ON Semiconductor: FDS9958\_F085 FDS9958-F085